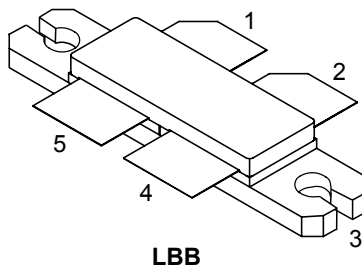


250 W 28/32 V RF power LDMOS transistor from HF to 1 GHz



Features

Order code	Frequency	V _{DD}	P _{OUT}	Gain	Efficiency
RF3L05250CB4	650 MHz	28 V	250 W	18 dB	62 %

- High efficiency and linear gain operations
- Integrated ESD protection
- Large positive and negative gate/source voltage range for improved class C operation
- In compliance with the European Directive 2002/95/EC

Applications

- 2-30 MHz HF or short wave communication
- 30-88 MHz ground communication
- 118-140 MHz Avionics
- 136-174 MHz commercial ground communication
- 30-512 MHz Jammer, ground/air communication
- HF to 1000 MHz ISM - instrumentation

Description

The RF3L05250CB4 is a 250 W 28/32 V LDMOS FET designed for wide-band communication and ISM applications with frequencies from HF to 1 GHz. It can be used in class AB/B and C for all typical modulation formats.

Pin connection	
Pin	Connection
1	Drain A
2	Drain B
3	Source (bottom side)
4	Gate B
5	Gate A

Product status link
RF3L05250CB4

Product summary	
Order code	RF3L05250CB4
Marking	RF3L05250CB4
Package	LBB
Packing	Tape and reel 13"
Base/bulk quantity	100/100

1 Electrical data

1.1 Absolute ratings

Table 1. Absolute maximum ratings ($T_{CASE} = 25\text{ °C}$)

Symbol	Parameter	Value	Unit
$V_{(BR)DSS}$	Drain-source voltage	90	V
V_{GS}	Gate-source voltage	-8/+10	V
V_{DD}	Maximum operating voltage	36	V
T_J	Maximum junction temperature	+200	°C
T_{STG}	Storage temperature range	-65 to +150	°C

1.2 Thermal data

Table 2. Thermal data

Symbol	Parameter	Value	Unit
$R_{thj-case}$	Junction-case thermal resistance	0.32	°C/W

Note: $T_{CASE} = +85\text{ °C}$, $T_J = +200\text{ °C}$, DC test.

1.3 ESD protection characteristics

Table 3. ESD protection

Symbol	Test methodology	Class
HBM	Human body model (per JESD22-A114)	2

2 Electrical characteristics

($T_{CASE} = 25\text{ }^{\circ}\text{C}$ unless otherwise specified)

2.1 Static

Table 4. Static

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$V_{(BR)DSS}$	Drain-source breakdown voltage	$V_{GS} = 0\text{ V}$, $I_{DS} = 100\text{ }\mu\text{A}$	90			V
I_{DSS}	Zero gate voltage drain leakage current	$V_{GS} = 0\text{ V}$, $V_{DS} = 28\text{ V}$			1	μA
		$V_{GS} = 0\text{ V}$, $V_{DS} = 75\text{ V}$				
I_{GSS}	Gate-source leakage current	$V_{GS} = 10\text{ V}$, $V_{DS} = 0\text{ V}$			100	nA
$V_{GS(th)}$	Gate threshold voltage	$V_{DS} = 42\text{ V}$, $I_{DS} = 600\text{ }\mu\text{A}$	1.75		2.5	V
$V_{GS(Q)}$	Gate quiescent voltage	$V_{DS} = 28\text{ V}$, $I_{DS} = 700\text{ mA}$		3.0		V
$V_{DS(on)}$	Static drain-source on-voltage	$V_{GS} = 10\text{ V}$, $I_{DS} = 3\text{ A}$			550	mV
$I_{DS(on)}$	Static drain-source on-current	$V_{GS} = 10\text{ V}$, $V_{DS} = 100\text{ mV}$			2.5	A
$R_{DS(on)}$	Drain-source on-state resistance	$V_{GS} = 10\text{ V}$, $V_{DS} = 100\text{ mV}$			1	Ω
C_{ISS}	Common source input capacitance	$V_{GS} = 0\text{ V}$, $V_{DD} = 28\text{ V}$, $f = 1\text{ MHz}$		128		pF
C_{RSS}	Common source feedback capacitance			2.4		pF
C_{OSS}	Common source output capacitance			43		pF

2.2 Dynamic

Table 5. Dynamic

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
f	Frequency				1000	MHz
P_{OUT}	Output power	f = 650 MHz, at 1dB compression point		250		W
G_{PS}	Power gain			18		dB
η_D	Drain efficiency			62		%
VSWR	Load mismatch	At 250 W pulse CW output power , all phase angles			20:1	

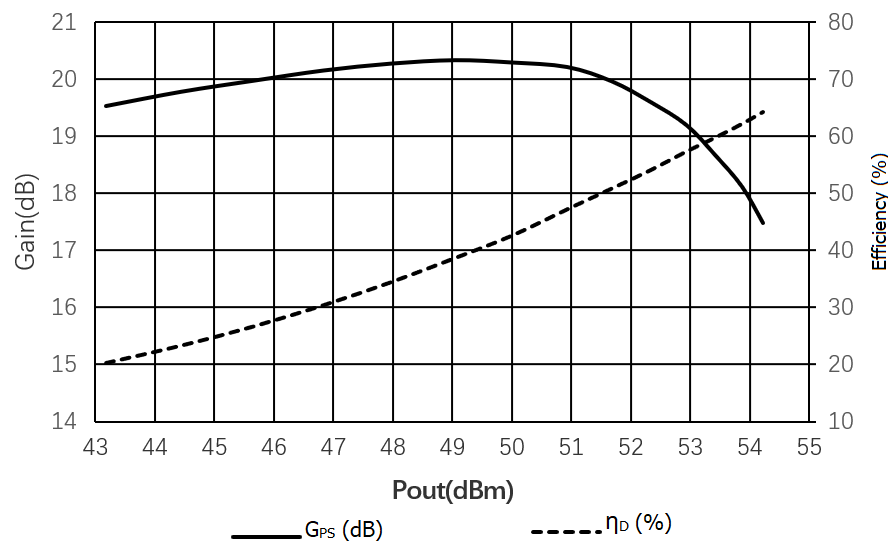
Note: $V_{DD} = 28\text{ V}$, $I_{DQ} = 100\text{ mA}$, CW signal measurement.

3 Typical performances

Table 6. Output power, power gain and drain efficiency vs input power (f = 650 MHz)

P _{IN} (dBm)	P _{OUT} (dBm)	P _{OUT} (W)	I _{DS} (A)	G _{PS} (dB)	η _D (%)
23.65	43.18	21	3.65	19.53	20
24.67	44.45	28	4.25	19.78	23
25.68	45.65	37	4.91	19.97	27
26.69	46.84	48	5.66	20.15	30
27.7	47.97	63	6.49	20.27	34
28.72	49.05	80	7.41	20.33	39
29.71	50	100	8.38	20.29	43
30.73	50.94	124	9.38	20.21	47
31.73	51.69	148	10.35	19.96	51
32.74	52.34	171	11.31	19.6	54
33.74	52.94	197	12.25	19.2	57
34.76	53.43	220	13.15	18.67	60
35.76	53.88	244	14.02	18.12	62
36.74	54.23	265	14.71	17.49	64

Figure 1. Power gain and drain efficiency versus output power (f = 650 MHz)



Note: $V_{DD} = 28\text{ V}$, $I_{DQ} = 100\text{ mA}$, CW signal measurement.

4 Test circuit

4.1 Test circuit layout

Figure 2. Test circuit layout (f = 650 MHz)

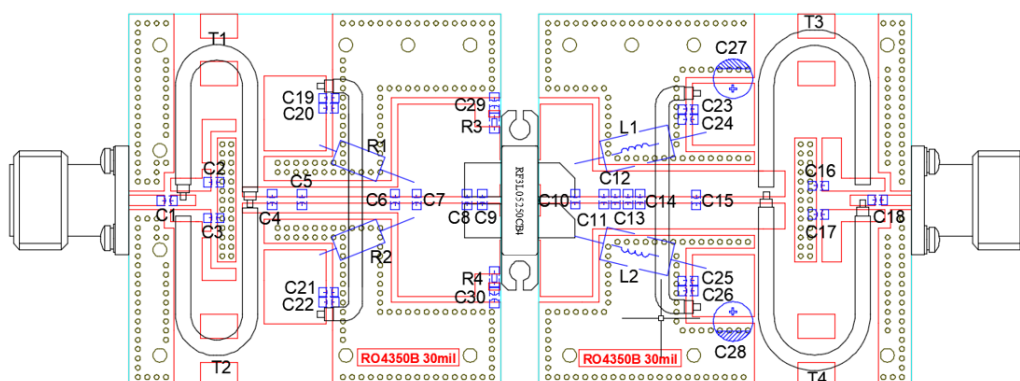


Figure 3. Test circuit photo

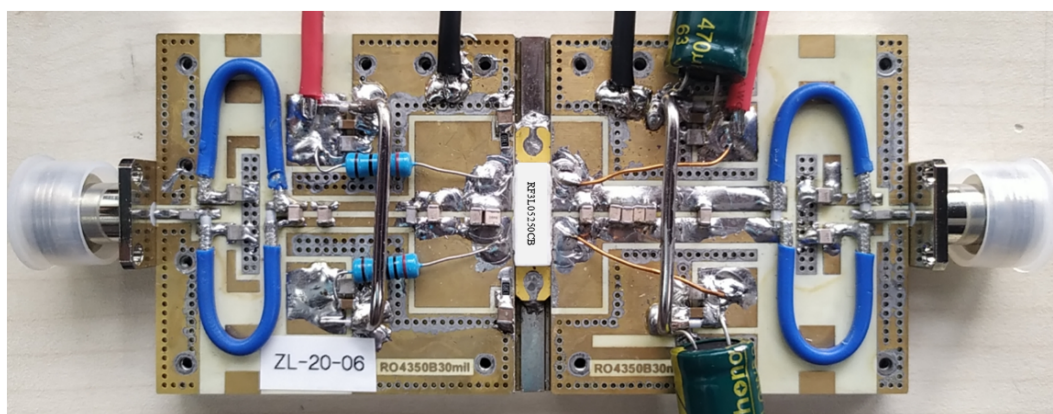


Table 7. Components list

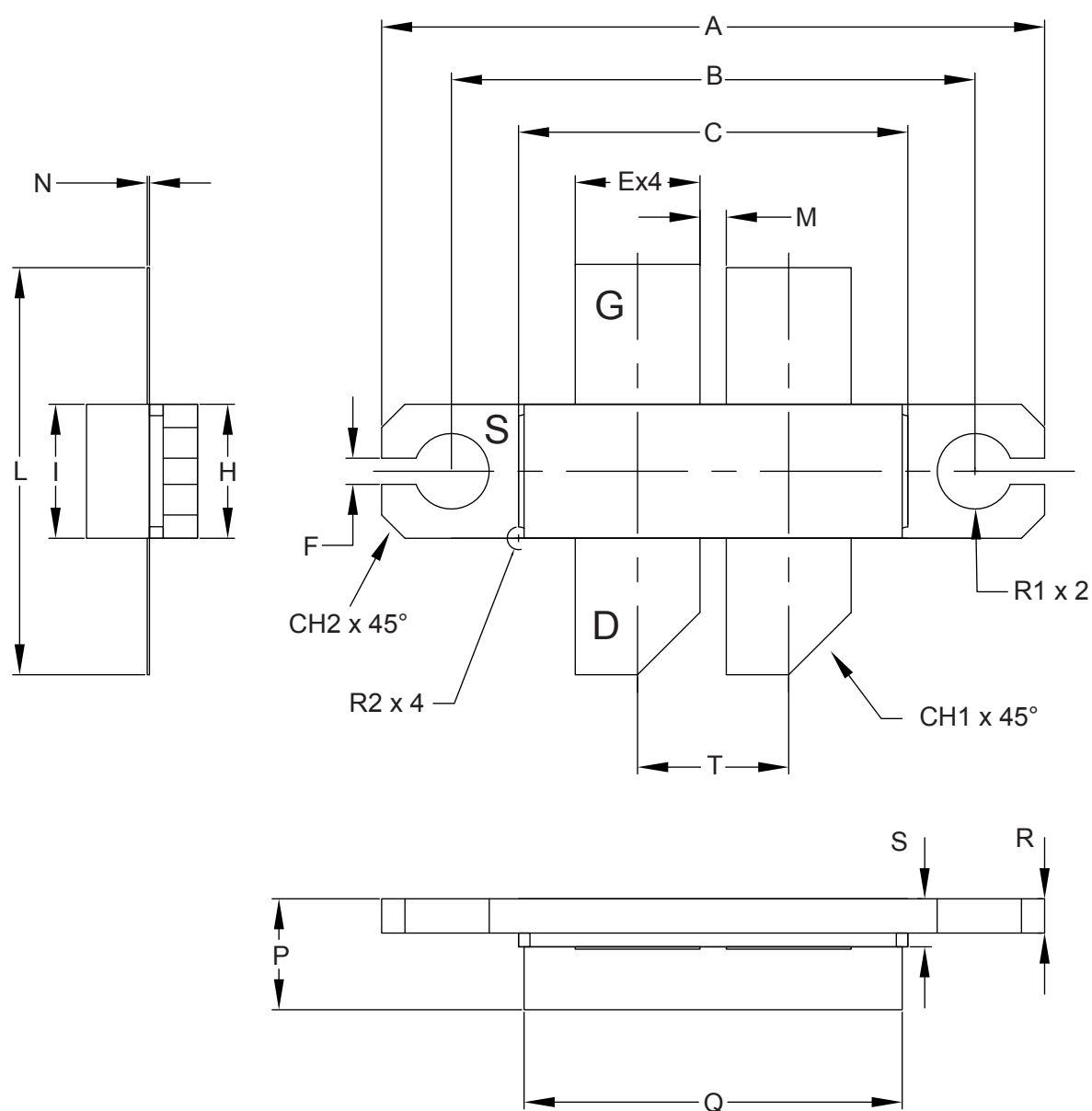
Component	Value	Order code
C1, C18, C20, C21, C24, C25	47 pF	ATC800B
C2, C3	120 pF	ATC800B
C4, C5	2 pF	DLC70B
C6, C12	10 pF	ATC800B
C7	20 pF	DLC70B
C8, C10	15 pF	DLC70B
C9, C13	6.8 pF	DLC70B
C11	4.7 pF	DLC70B
C14	1.8 pF	DLC70B
C15	3.9 pF	DLC70B
C16, C17	240 pF	DLC70B
C29, C30	1000 pF	ATC800B
C19, C22, C23, C26	Ceramic multilayer capacitor, 10 uF, 50 V	10 uF / 50 V
C27, C28	Electrolytic capacitor , 470 uF, 63 V	
R1, R2	Metal film resistor, 200 Ω	
R3, R4	Chip resistor, 13 Ω , 0805	
L1, L2	Copper wire, cross section diameter 0.8 mm	
T1, T2, T3, T4	25 Ω , line length = 50 mm	SF-086-25
PCB	0.762 mm [0.030"] thick, $\epsilon_r = 3.48$, Rogers RO4350B, 1 oz. copper	

5 Package information

In order to meet environmental requirements, ST offers these devices in different grades of **ECOPACK** packages, depending on their level of environmental compliance. ECOPACK specifications, grade definitions and product status are available at: www.st.com. ECOPACK is an ST trademark.

5.1 LBB package information

Figure 4. LBB package outline



DM00666717_2

Table 8. LBB mechanical data

Symbol	Millimeters		
	Min.	Typ.	Max.
A	28.82	28.95	29.08
B	22.73	22.86	22.99
C	16.87	17.00	17.13
E	5.32	5.45	5.58
F	1.01	1.14	1.27
H	5.72	5.85	5.98
I	5.72	5.85	5.98
L	17.65	17.78	17.91
M	1.02	1.15	1.28
N		0.10	
P	4.72	4.85	4.98
Q	16.38	16.51	16.64
R	1.37	1.50	1.63
S	1.97	2.10	2.23
T		6.60	
CH1		2.72	
CH2		1.02	
R1		1.65	
R2		0.50	

Revision history

Table 9. Document revision history

Date	Version	Changes
16-Jun-2020	1	First release

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